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PASSIVE MILLIMETER-WAVE IMAGING WITH EXTENDED DEPTH OF FIELD AND SPARSE DATA

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ABSTRACT

In this paper, we introduce a new millimeter wave imaging modality with extended depth-of-field that provides diffraction limited images based on a significant reduction in scan-time. The technique uses a cubic phase element in the pupil of the system and a non-linear recovery algorithm to produce images that are insensitive to object distance. We present experimental results that validate system performance and demonstrate a greater than four-fold increase in depth-of-field with a reduction in scan-time by a factor of at least two.

Index Terms— Computational imaging, millimeter wave imaging, extended depth-of-field, image reconstruction, sparsity.

1. INTRODUCTION

Over the past several years, imaging using millimeter wave (mmW) and terahertz technology has gained a lot of interest [1], [2], [3]. This interest is, in part, driven by the ability to penetrate poor weather and other obscurants such as clothes and polymers. Millimeter waves are high-frequency electromagnetic waves usually defined to be in the 30 to 300 GHz range with corresponding wavelengths between 10 to 1mm. Radiation at these these frequencies is non-ionizing and is safe to use on people. Applications of this technology include the detection of concealed weapons, explosives and contraband. Fig. 1 compares a visible image and corresponding 94-GHz image of two people with various weapons concealed under clothing. Note that concealed weapons are clearly detected in the mmW image.

Recently, in [3], Mait \textit{et al.} presented a computational imaging method to extend the depth-of-field of a passive mmW imaging system. The method uses a cubic phase element in the pupil plane of the system to render system operation relatively insensitive to object distance. The aberrations introduced by the cubic phase elements are then removed by post-detection signal processing. It was shown that, one can increase the depth-of-field of a 94GHz imager four times its normal depth-of-field [3].

Several other systems have also been developed and discussed in the literature [1], [2]. Some of them use a single-beam system that forms an image by scanning in azimuth and elevation. One of the main drawbacks of mechanical scanning is that it significantly limits the acquisition speed. For instance, it takes about 15 seconds for a 94-GHz imager to scan a 30°-by-30° angular sector. Real-time mmW imaging has also been demonstrated using an array of sensors. However, these systems introduce higher complexity and are costly. To deal with this, compressive sampling methods [4], [5] have been applied to mmW imaging which reduces the number of samples required to form an image [6], [7], [8], [9], [10], [11].

Fig. 1. Millimeter wave imaging through clothing. (a) Visible image of the scene. (b) Image produced using a 94-GHz imaging system.

In this paper, we describe a passive mmW imaging system with extended depth-of-field that can produce images with reduced number of samples. We show that if the mmW image is assumed to be sparse in some transform domain, then one can reconstruct a good estimate of the image using this new image formation algorithm. Our method relies on using a far fewer number of measurements than the conventional systems do and can reduce the scan-time significantly.

The organization of the paper is as follows. Section 2 provides background information on passive mmW imaging using a 94GHz system. The proposed undersampling scheme is described in Section 3. We demonstrate experimental results in Section 4 and Section 5 concludes the paper with a brief summary and discussion.

2. BACKGROUND

A schematic diagram of our mmW imaging system is shown in Fig. 2. It is a 94-GHz Stokes-vector radiometer used for mmW measurements. It is a single-beam system that produces images by scanning in horizontal and vertical axis. The radiometer has a thermal sensitivity of 0.3 K with a 30-ms integration time and 1-GHz bandwidth per pixel. A Cassegrain antenna is mounted to the front of the radiometer receiver that has 24" diameter primary parabolic reflector and a 1.75" diameter secondary hyperbolic reflector. The position of the hyperbolic secondary is variable.

One can model the 94-GHz imaging system as a linear, spatially incoherent, quasi-monochromatic system [3]. The intensity of the detected image can be represented as a convolution between the intensity of the image predicted by the geometrical optics with the
A post-detection signal processing step is usually employed to remove the artifacts of the aberrations introduced by the cubic phase element to produce a well-defined sharp response [13], [14], [15]. Assuming a linear process

\[ i_p(x, y) = \mathbf{i}(x, y) * \mathbf{w}(x, y) \]  

one can implement \( \mathbf{w}(x, y) \) as a Wiener filter in the Fourier space

\[ W(u, v) = \frac{H^*_c(u, v)}{|H_c(u, v)|^2 + \frac{\Phi_c(u, v)}{\Phi_N(u, v)}} \]

where \( H_c(u, v) \) is the optical transfer function associated with the cubic phase element, the parameter \( K \) is a measure of the signal-to-noise ratio, the functions \( \Phi_c \) and \( \Phi_N \) are the expected power spectra of the object and noise, respectively. The optical transfer function is usually estimated from the experimentally measured point responses. One can view the estimated \( i_p \) as a diffraction limited response. In the matrix notation, one can rewrite eq. (5) as

\[ i_p = \mathbf{W}i = \mathbf{W}\Phi_0 \]

where \( i_p \) is the \( N^2 \times 1 \) column vector corresponding to array \( i_p(x, y) \) and \( \mathbf{W} \) is the \( N^2 \times N^2 \) convolution matrix corresponding to the Wiener filter \( \mathbf{w}(x, y) \).

3. ACCELERATED IMAGING WITH EXTENDED DEPTH-OF-FIELD

Since our objective is to form mmW images with reduced number of samples, we propose the following sampling strategy. Our sensor is a single-beam system that produces images by scanning in azimuth and elevation. One can reduce the number of samples by randomly
undersampling in both azimuth and elevation. Mathematically, this amounts to introducing a mask in eq. (1) as follows

\[ i_M = M_i = M_i Ho_y, \]  

(8)

where \( i_M \) is an \( N^2 \times 1 \) lexicographically ordered column vector of observations with missing information. Here, \( M \) is the degradation operator that removes the \( p \) samples from the signal. This matrix is of size \( N^2 \times N^2 \), built by taking the \( N^2 \times N^2 \) identity matrix with \( p \) zeros in the diagonal correspond to the discarded samples.

To remove the artifacts of the aberrations introduced by the cubic phase element a Wiener filter can be implemented as shown in eq. (5). Then, the observation model can be written as

\[ i_o = W_i M_i = W M_i = W M_i Ho_y. \]  

(9)

Using the relation in eq. (7), one can write \( H_o y \) in terms of the diffraction limited response, \( i_p \), as

\[ H_o y = G_{i_p}, \]  

(10)

where, \( G \) is the regularized inverse filter corresponding to \( W \). With this, and assuming the presence of additive noise \( \eta \), one can rewrite the observation model (9) as

\[ i_o = W M G_{i_p} + \eta. \]  

(11)

where \( \eta \) denotes the \( N^2 \times 1 \) column vector corresponding to noise, \( \eta \). We assume that \( ||\eta||^2 = \epsilon^2 \).

Having observed \( i_o \) and knowing the matrices \( W, M \) and \( G \), the general problem is to estimate the diffraction limited response, \( i_p \). Assume that \( i_o \) is sparse or compressible in a basis or frame \( \Psi \) so that \( i_o = \Psi \alpha \) with \( ||\alpha||_0 = K \ll N^2 \), where the \( \ell_0 \) sparsity measure \( ||\cdot||_0 \) counts the number of nonzero elements in the representation. The observation model (11) can now be rewritten as

\[ i_o = W M G \Psi \alpha + \eta. \]  

(12)

This is a classic inverse problem whose solution can be obtained by solving the following optimization problem

\[ \hat{\alpha} = \arg \min_{\alpha} ||\alpha||_1 \quad \text{subject to} \quad ||i_o - W M G \Psi \alpha||_2 \leq \epsilon. \]  

(13)

Once the representation vector \( \alpha \) is estimated, we obtain the final estimate of \( i_p \) as \( i_p = \Psi \hat{\alpha} \). Note that the recovery of \( \alpha \) from eq. (12) will depend on certain conditions on the sensing matrix \( WMG \Psi \) and the sparsity of \( \alpha \) [16].

4. EXPERIMENTAL RESULTS

In this section, we demonstrate the performance and applicability of our method on simulated data with the measured PSFs. In these experiments, we use an orthogonal wavelet transform (Daubechies 4 wavelet) as a sparsifying transform. There has been a number of approaches suggested for solving optimization problems such as eq. (13). In our approach, we employ a highly efficient algorithm that is suitable for large scale applications known as the Gradient Projection for Sparse Reconstruction (GPSR) algorithm [17].

The extended object used in our experiments is represented in Fig. 4(a). Images of an extended object for conventional imaging system at 113°, 146° and 180° are shown in Fig. 5(a)-(c), respectively. Note that the conventional imaging system produces images with significant blurring. In contrast, even without signal processing, the images produced with cubic phase element retain more discernable characteristics of the object than the images from the conventional system, as shown in Fig. 5(d)-(f). It can be seen from Fig. 5(g)-(i) that post processing removes the artifacts of aberrations introduced by the cubic phase element and produces sharp images. Hence, one can extend the region over which the system generates diffraction limited images. In fact, in [3], it was shown that the DoF of a conventional 94GHz imaging system can be extended from 17.4° to more than 68°.
The reconstructions of the extended object are comparable to the processed images from a system with cubic phase. This can be seen by comparing Fig. 5(g)-(i) with Fig. 7(d)-(f).

In Fig. 6(b), shows the peak-signal-to-noise-ratio (PSNR) curves as we vary the number of measurements. We see that with increase in number of measurements the reconstruction quality generally improves. It is interesting to note that the PSNR values stay about the same after 50% of the measurements are taken. Furthermore, reconstruction curves corresponding to all three distances 113”, 146” and 180” follow the similar curves, showing the depth invariance of the system. These figure shows that it is indeed possible to extended depth-of-field even when cubic phase data is sparsely sampled.

5. DISCUSSION AND CONCLUSION

We have utilized a computational imaging technique along with a nonlinear reconstruction method and demonstrated that extended depth-of-field is possible for passive millimeter wave imaging even when the cubic phase data is sparsely sampled.

Millimeter wave systems image temperature contrasts. Hence, careful analysis of noise and contrast in such systems is necessary to assess the impact of inserting a cubic phase element in the pupil plane of the system and sparsely sampling the data. More analysis on the artifacts introduced by the cubic phase element and random undersampling in terms of the point spread function will be discussed elsewhere (see [18] for more details).

6. REFERENCES


